FAIRCHILD SEMICONDUCTOR®

September 2011

FDMC7692

N-Channel Power Trench® MOSFET

30 V, 13.3 A, 8.5 mΩ

Features

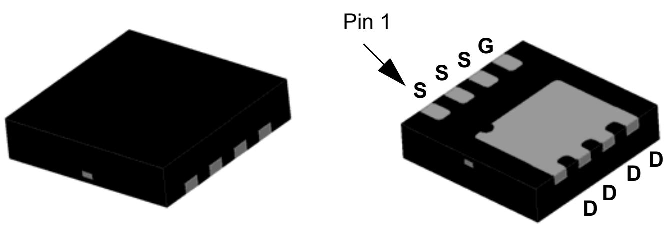
- Max $r_{DS(on)}$ = 8.5 mΩ at V_{GS} = 10 V, I_D = 13.3 A
- Max $r_{DS(on)}$ = 11.5 mΩ at V_{GS} = 4.5 V, I_D = 10.6 A
- High performance technology for extremely low $r_{DS(on)}$
- Termination is Lead-free and RoHS Compliant

General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Application

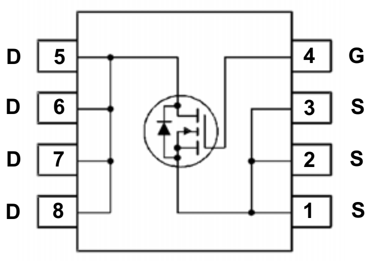
- DC - DC Buck Converters
- Notebook battery power management
- Load switch in Notebook



Top

Bottom

MLP 3.3x3.3



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
I_D	Drain Current -Continuous (Package limited)	T_C = 25 °C		16	A
	-Continuous	T_A = 25 °C	(Note 1a)	13.3	
	-Pulsed			40	
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	58	mJ
P_D	Power Dissipation	T_C = 25 °C		29	W
	Power Dissipation	T_A = 25 °C	(Note 1a)	2.3	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		4.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC7692	FDMC7692	MLP 3.3x3.3	13 ”	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units

Off Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 µA, V_{GS} = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C		16		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 24 V, V_{GS} = 0 V			1	µA
		T_J = 125 °C			250	
I_{GSS}	Gate to Source Leakage Current	V_{GS} = 20 V, V_{DS} = 0 V			100	nA

On Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 µA	1.2	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C		-6		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 13.3 A		7.2	8.5	mΩ
		V_{GS} = 4.5 V, I_D = 10.6 A		9.5	11.5	
		V_{GS} = 10 V, I_D = 13.3 A, T_J = 125 °C		9.5	12.0	
g_{FS}	Forward Transconductance	V_{DD} = 5 V, I_D = 13.3 A		60		S

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
C_{iss}	Input Capacitance	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz		1260	1680	pF
C_{oss}	Output Capacitance			480	635	pF
C_{rss}	Reverse Transfer Capacitance			65	100	pF
R_g	Gate Resistance			0.9	2.4	Ω

Switching Characteristics

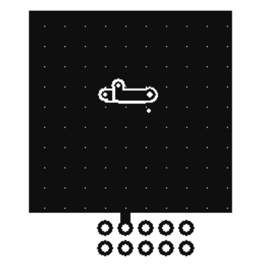
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 15 V, I_D = 13.3 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		9	18	ns
t_r	Rise Time			4	10	ns
$t_{d(off)}$	Turn-Off Delay Time			21	33	ns
t_f	Fall Time			3	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to 10 V V_{DD} = 15 V I_D = 13.3 A		21	29	nC
	Total Gate Charge	V_{GS} = 0 V to 4.5 V		10	14	nC
Q_{gs}	Total Gate Charge			5		nC
Q_{gd}	Gate to Drain “Miller” Charge			3		nC

Drain-Source Diode Characteristics

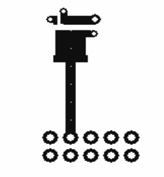
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 13.3 A (Note 2)		0.86	1.2	V
		V_{GS} = 0 V, I_S = 1.9 A (Note 2)		0.75	1.2	
t_{rr}	Reverse Recovery Time	I_F = 13.3 A, di/dt = 100 A/µs		24	38	ns
Q_{rr}	Reverse Recovery Charge			7	14	nC

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in^2 pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0 %.

3. E_{AS} of 58 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 10.8 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 21 A.

Typical Characteristics T_J = 25 °C unless otherwise noted

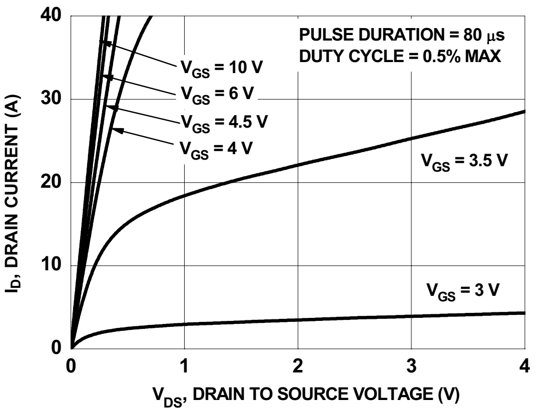


Figure 1. On-Region Characteristics

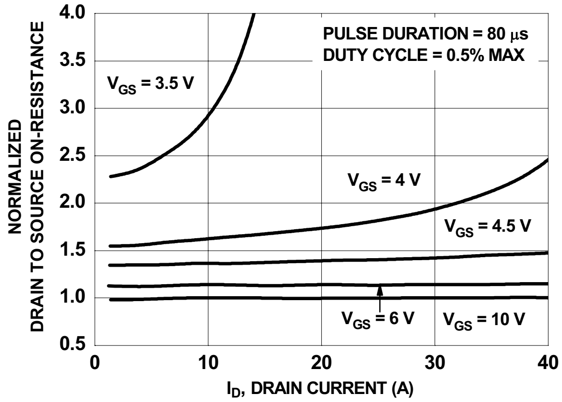


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

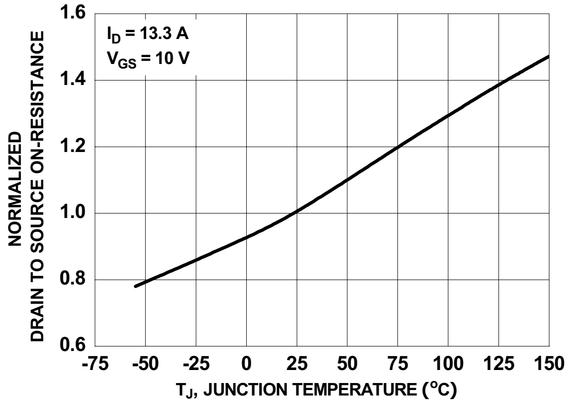


Figure 3. Normalized On-Resistance vs Junction Temperature

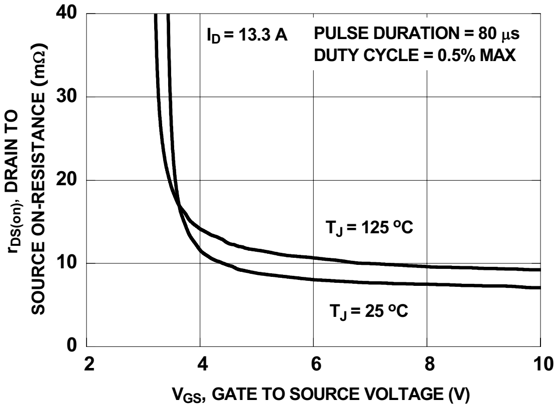


Figure 4. On-Resistance vs Gate to Source Voltage

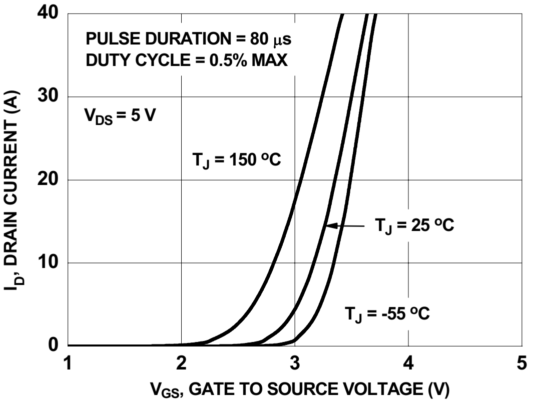


Figure 5. Transfer Characteristics

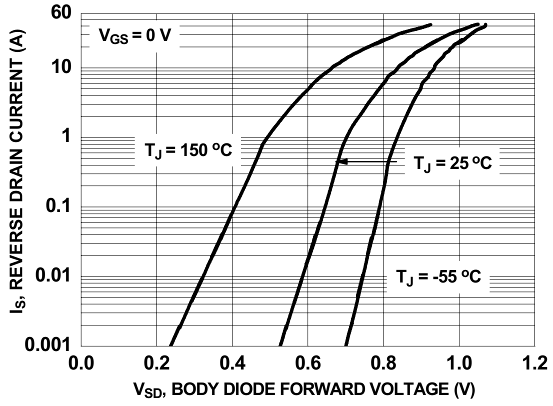


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

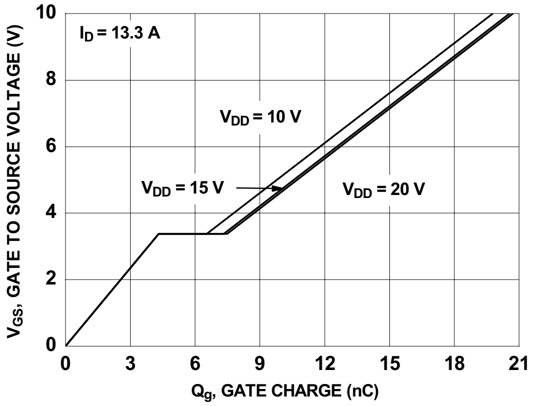


Figure 7. Gate Charge Characteristics

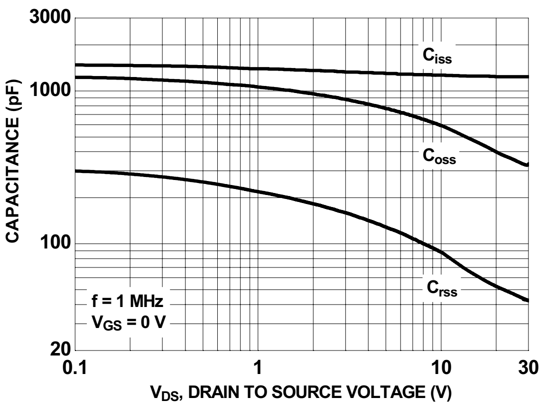


Figure 8. Capacitance vs Drain to Source Voltage

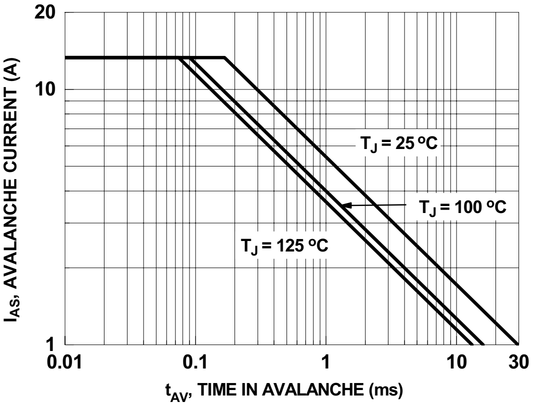


Figure 9. Unclamped Inductive Switching Capability

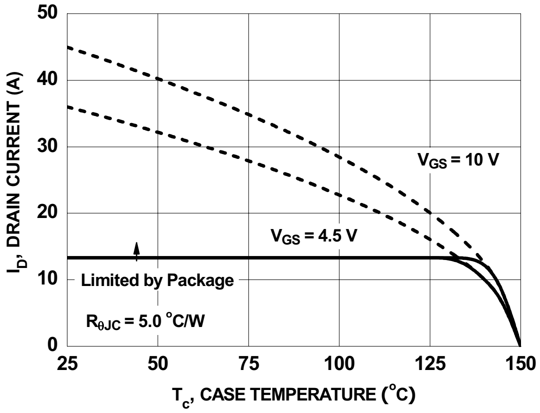


Figure 10. Maximum Continuous Drain Current vs Case Temperature

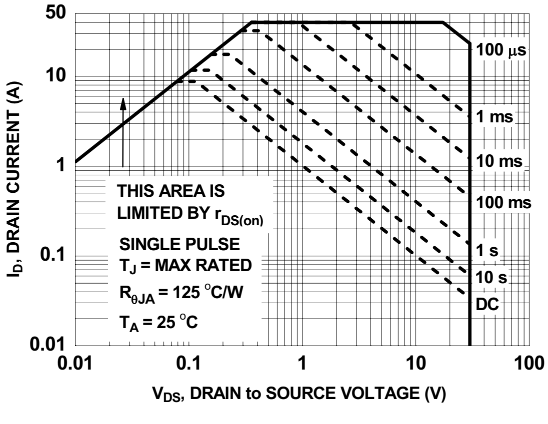


Figure 11. Forward Bias Safe Operating Area

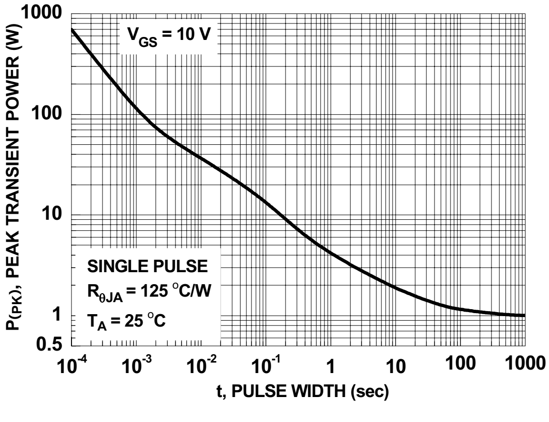


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

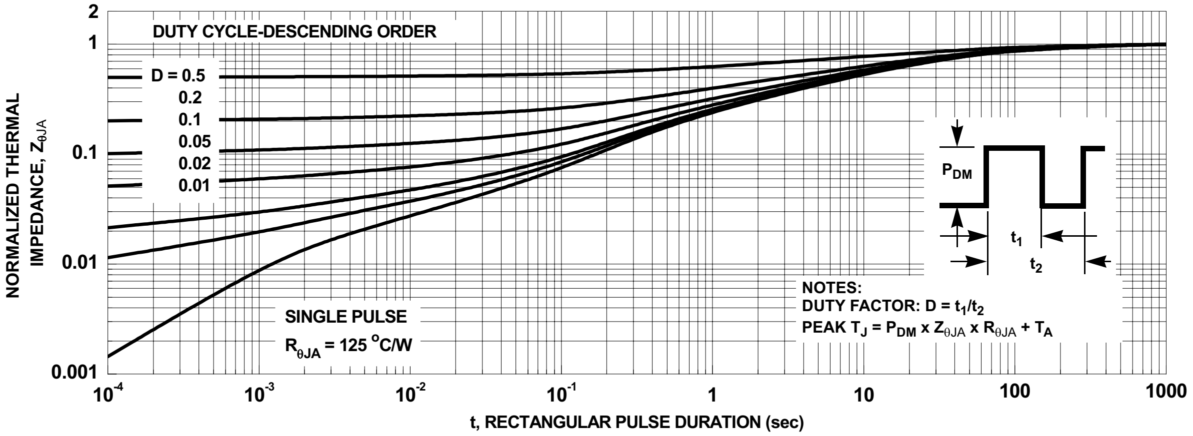
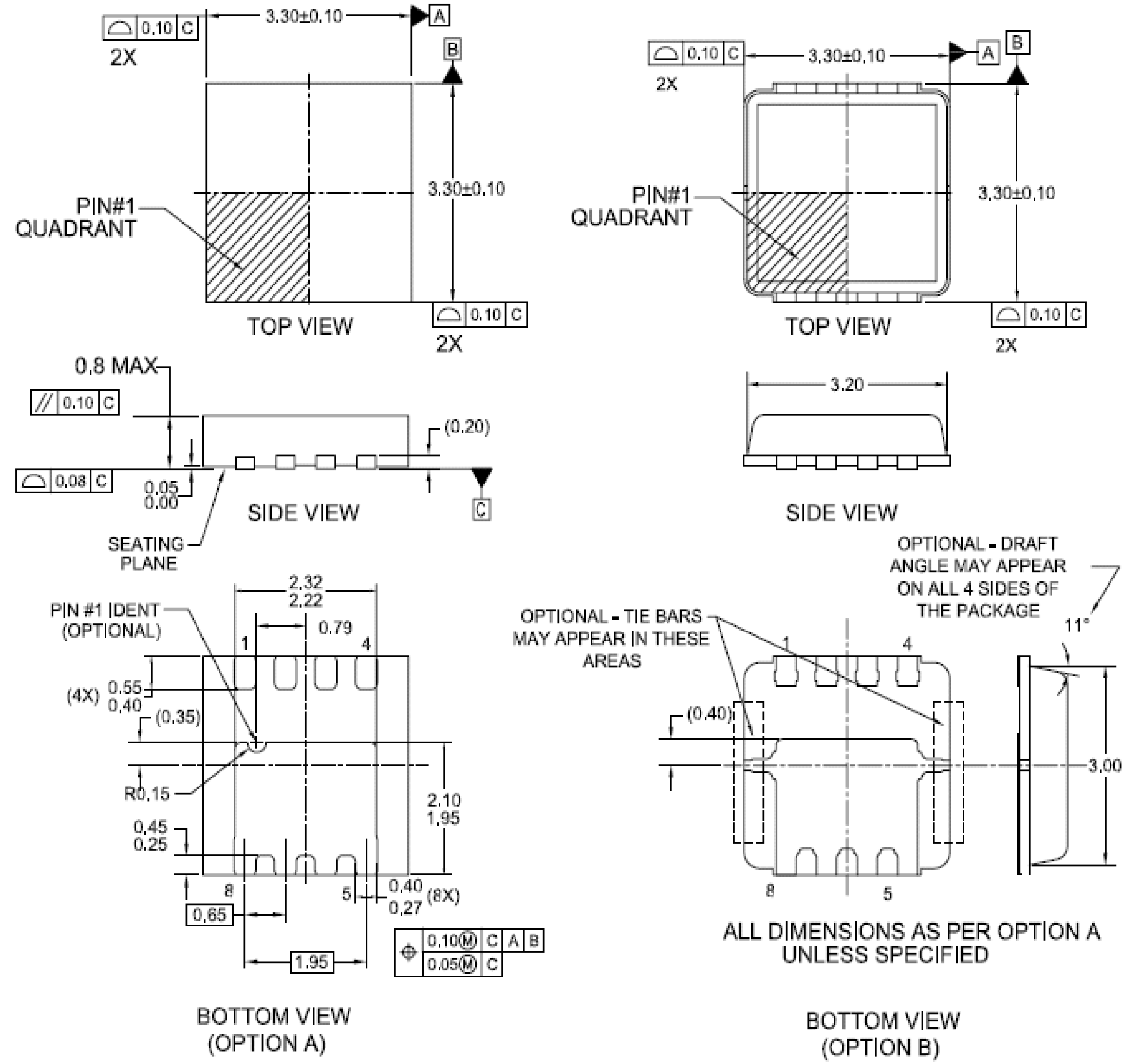
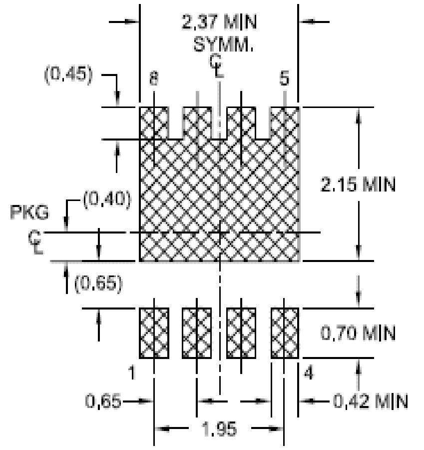


Figure 13. Transient Thermal Response Curve

Dimensional Outline and Pad Layout





NOTES:

A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-240.
B. DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
D. DIMENSIONS DOES NOT INCLUDE BURRS OR MOLD FLASH. BURRS OR MOLD FLASH SHALL NOT EXCEED 0.10MM.
E. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY.
F. DRAWING FILENAME; MKT-MLP08Wrev1.
G. OPTION A - SAWN MLP.
OPTION B - PUNCH MLP.

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